

## MOSFET

### 650V CoolMOS™ CE Power Transistor

CoolMOS™ is a revolutionary technology for high voltage power MOSFETs, designed according to the superjunction (SJ) principle and pioneered by Infineon Technologies. CoolMOS™ CE is a price-performance optimized platform enabling to target cost sensitive applications in Consumer and Lighting markets by still meeting highest efficiency standards. The new series provides all benefits of a fast switching Superjunction MOSFET while not sacrificing ease of use and offering the best cost down performance ratio available on the market.

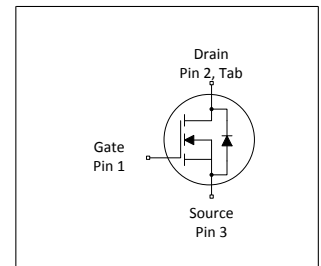
### Features

- Extremely low losses due to very low FOM  $R_{DS(on)} \cdot Q_g$  and  $E_{oss}$
- Very high commutation ruggedness
- Easy to use/drive
- Pb-free plating, Halogen free mold compound
- Qualified for standard grade applications

### Applications

PFC stages, hard switching PWM stages and resonant switching stages for e.g. PC Silverbox, Adapter, LCD & PDP TV and indoor lighting.

*Please note: For MOSFET paralleling the use of ferrite beads on the gate or separate totem poles is generally recommended.*



**Table 1 Key Performance Parameters**

| Parameter            | Value | Unit |
|----------------------|-------|------|
| $V_{DS} @ T_{j,max}$ | 700   | V    |
| $R_{DS(on),max}$     | 1500  | mΩ   |
| $I_d$                | 5.2   | A    |
| $Q_{g,typ}$          | 10.5  | nC   |
| $I_{D,pulse}$        | 8.3   | A    |
| $E_{oss}@400V$       | 1.15  | μJ   |

| Type / Ordering Code | Package           | Marking  | Related Links  |
|----------------------|-------------------|----------|----------------|
| IPA65R1K5CE          | PG-TO 220 FullPAK | 65S1K5CE | see Appendix A |

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## 1 Maximum ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

**Table 2 Maximum ratings**

| Parameter                                    | Symbol        | Values |      |            | Unit             | Note / Test Condition                                                                 |
|----------------------------------------------|---------------|--------|------|------------|------------------|---------------------------------------------------------------------------------------|
|                                              |               | Min.   | Typ. | Max.       |                  |                                                                                       |
| Continuous drain current <sup>1)</sup>       | $I_D$         | -      | -    | 5.2<br>3.3 | A                | $T_C=25^\circ\text{C}$<br>$T_C=100^\circ\text{C}$                                     |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$ | -      | -    | 8.3        | A                | $T_C=25^\circ\text{C}$                                                                |
| Avalanche energy, single pulse               | $E_{AS}$      | -      | -    | 26         | mJ               | $I_D=0.6\text{A}$ ; $V_{DD}=50\text{V}$ ; see table 10                                |
| Avalanche energy, repetitive                 | $E_{AR}$      | -      | -    | 0.10       | mJ               | $I_D=0.6\text{A}$ ; $V_{DD}=50\text{V}$ ; see table 10                                |
| Avalanche current, repetitive                | $I_{AR}$      | -      | -    | 0.6        | A                | -                                                                                     |
| MOSFET dv/dt ruggedness                      | dv/dt         | -      | -    | 50         | V/ns             | $V_{DS}=0\dots480\text{V}$                                                            |
| Gate source voltage (static)                 | $V_{GS}$      | -20    | -    | 20         | V                | static;                                                                               |
| Gate source voltage (dynamic)                | $V_{GS}$      | -30    | -    | 30         | V                | AC ( $f>1\text{ Hz}$ )                                                                |
| Power dissipation (Non- Full PAK)            | $P_{tot}$     | -      | -    | 53         | W                | $T_C=25^\circ\text{C}$                                                                |
| Storage temperature                          | $T_{stg}$     | -40    | -    | 150        | $^\circ\text{C}$ | -                                                                                     |
| Operating junction temperature               | $T_j$         | -40    | -    | 150        | $^\circ\text{C}$ | -                                                                                     |
| Continuous diode forward current             | $I_S$         | -      | -    | 3.7        | A                | $T_C=25^\circ\text{C}$                                                                |
| Diode pulse current <sup>2)</sup>            | $I_{S,pulse}$ | -      | -    | 8.3        | A                | $T_C=25^\circ\text{C}$                                                                |
| Reverse diode dv/dt <sup>3)</sup>            | dv/dt         | -      | -    | 15         | V/ns             | $V_{DS}=0\dots400\text{V}$ , $I_{SD}\leq I_S$ , $T_j=25^\circ\text{C}$<br>see table 8 |
| Maximum diode commutation speed              | di/dt         | -      | -    | 500        | A/ $\mu\text{s}$ | $V_{DS}=0\dots400\text{V}$ , $I_{SD}\leq I_S$ , $T_j=25^\circ\text{C}$<br>see table 8 |
| Power dissipation (Full PAK)                 | $P_{tot}$     | -      | -    | 30         | W                | -                                                                                     |
| Mounting torque (FullPAK)<br>TO-220FP        | -             | -      | -    | 50         | Ncm              | M2.5 screws                                                                           |
| Insulation withstand voltage for<br>TO-220FP | $V_{ISO}$     | -      | -    | 2500       | V                | $V_{rms}$ , $T_C=25^\circ\text{C}$ , $t=1\text{min}$                                  |

<sup>1)</sup> Limited by  $T_{j,max}$ , TO252 equivalent, Maximum duty cycle  $D=0.50$

<sup>2)</sup> Pulse width  $t_p$  limited by  $T_{j,max}$

<sup>3)</sup> Identical low side and high side switch with identical  $R_G$

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                  | Symbol     | Values |      |      | Unit | Note / Test Condition               |
|------------------------------------------------------------|------------|--------|------|------|------|-------------------------------------|
|                                                            |            | Min.   | Typ. | Max. |      |                                     |
| Thermal resistance, junction - case                        | $R_{thJC}$ | -      | -    | 4.2  | °C/W | -                                   |
| Thermal resistance, junction - ambient                     | $R_{thJA}$ | -      | -    | 62   | °C/W | lead                                |
| Soldering temperature, wavesoldering only allowed at leads | $T_{sld}$  | -      | -    | 260  | °C   | 1.6mm (0.063 in.) from case for 10s |

### 3 Electrical characteristics

at  $T_j=25^\circ\text{C}$ , unless otherwise specified

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |              |      | Unit     | Note / Test Condition                                                                                       |
|----------------------------------|---------------|--------|--------------|------|----------|-------------------------------------------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.         | Max. |          |                                                                                                             |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 650    | -            | -    | V        | $V_{GS}=0V$ , $I_D=1mA$                                                                                     |
| Gate threshold voltage           | $V_{(GS)th}$  | 2.5    | 3.0          | 3.5  | V        | $V_{DS}=V_{GS}$ , $I_D=0.1mA$                                                                               |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | -            | 1    | $\mu A$  | $V_{DS}=650$ , $V_{GS}=0V$ , $T_j=25^\circ\text{C}$<br>$V_{DS}=650$ , $V_{GS}=0V$ , $T_j=150^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | -            | 100  | nA       | $V_{GS}=20V$ , $V_{DS}=0V$                                                                                  |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 1.26<br>3.28 | 1.50 | $\Omega$ | $V_{GS}=10V$ , $I_D=1A$ , $T_j=25^\circ\text{C}$<br>$V_{GS}=10V$ , $I_D=1A$ , $T_j=150^\circ\text{C}$       |
| Gate resistance                  | $R_G$         | -      | 6.5          | -    | $\Omega$ | $f=1MHz$ , open drain                                                                                       |

**Table 5 Dynamic characteristics**

| Parameter                                                  | Symbol       | Values |      |      | Unit | Note / Test Condition                                                         |
|------------------------------------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------|
|                                                            |              | Min.   | Typ. | Max. |      |                                                                               |
| Input capacitance                                          | $C_{iss}$    | -      | 225  | -    | pF   | $V_{GS}=0V$ , $V_{DS}=100V$ , $f=1MHz$                                        |
| Output capacitance                                         | $C_{oss}$    | -      | 18   | -    | pF   | $V_{GS}=0V$ , $V_{DS}=100V$ , $f=1MHz$                                        |
| Effective output capacitance, energy related <sup>1)</sup> | $C_{o(er)}$  | -      | 10   | -    | pF   | $V_{GS}=0V$ , $V_{DS}=0...480V$                                               |
| Effective output capacitance, time related <sup>2)</sup>   | $C_{o(tr)}$  | -      | 42   | -    | pF   | $I_D=\text{constant}$ , $V_{GS}=0V$ , $V_{DS}=0...480V$                       |
| Turn-on delay time                                         | $t_{d(on)}$  | -      | 7.7  | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=1.5A$ ,<br>$R_G=10.2\Omega$ ; see table 9 |
| Rise time                                                  | $t_r$        | -      | 5.9  | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=1.5A$ ,<br>$R_G=10.2\Omega$ ; see table 9 |
| Turn-off delay time                                        | $t_{d(off)}$ | -      | 33   | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=1.5A$ ,<br>$R_G=10.2\Omega$ ; see table 9 |
| Fall time                                                  | $t_f$        | -      | 18.2 | -    | ns   | $V_{DD}=400V$ , $V_{GS}=13V$ , $I_D=1.5A$ ,<br>$R_G=10.2\Omega$ ; see table 9 |

**Table 6 Gate charge characteristics**

| Parameter             | Symbol        | Values |      |      | Unit | Note / Test Condition                            |
|-----------------------|---------------|--------|------|------|------|--------------------------------------------------|
|                       |               | Min.   | Typ. | Max. |      |                                                  |
| Gate to source charge | $Q_{gs}$      | -      | 1.3  | -    | nC   | $V_{DD}=480V$ , $I_D=1.5A$ , $V_{GS}=0$ to $10V$ |
| Gate to drain charge  | $Q_{gd}$      | -      | 5.8  | -    | nC   | $V_{DD}=480V$ , $I_D=1.5A$ , $V_{GS}=0$ to $10V$ |
| Gate charge total     | $Q_g$         | -      | 10.5 | -    | nC   | $V_{DD}=480V$ , $I_D=1.5A$ , $V_{GS}=0$ to $10V$ |
| Gate plateau voltage  | $V_{plateau}$ | -      | 5.4  | -    | V    | $V_{DD}=480V$ , $I_D=1.5A$ , $V_{GS}=0$ to $10V$ |

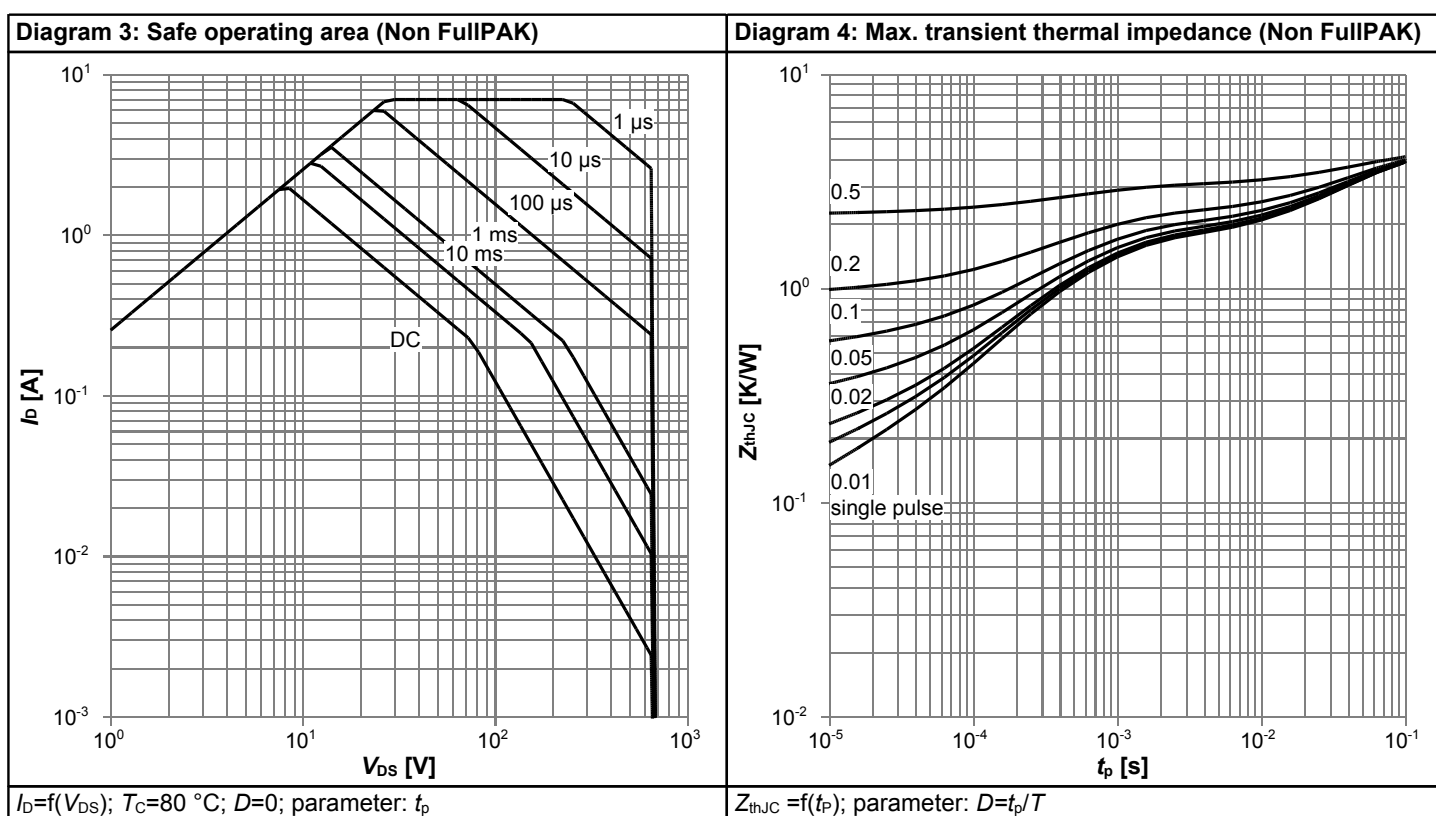
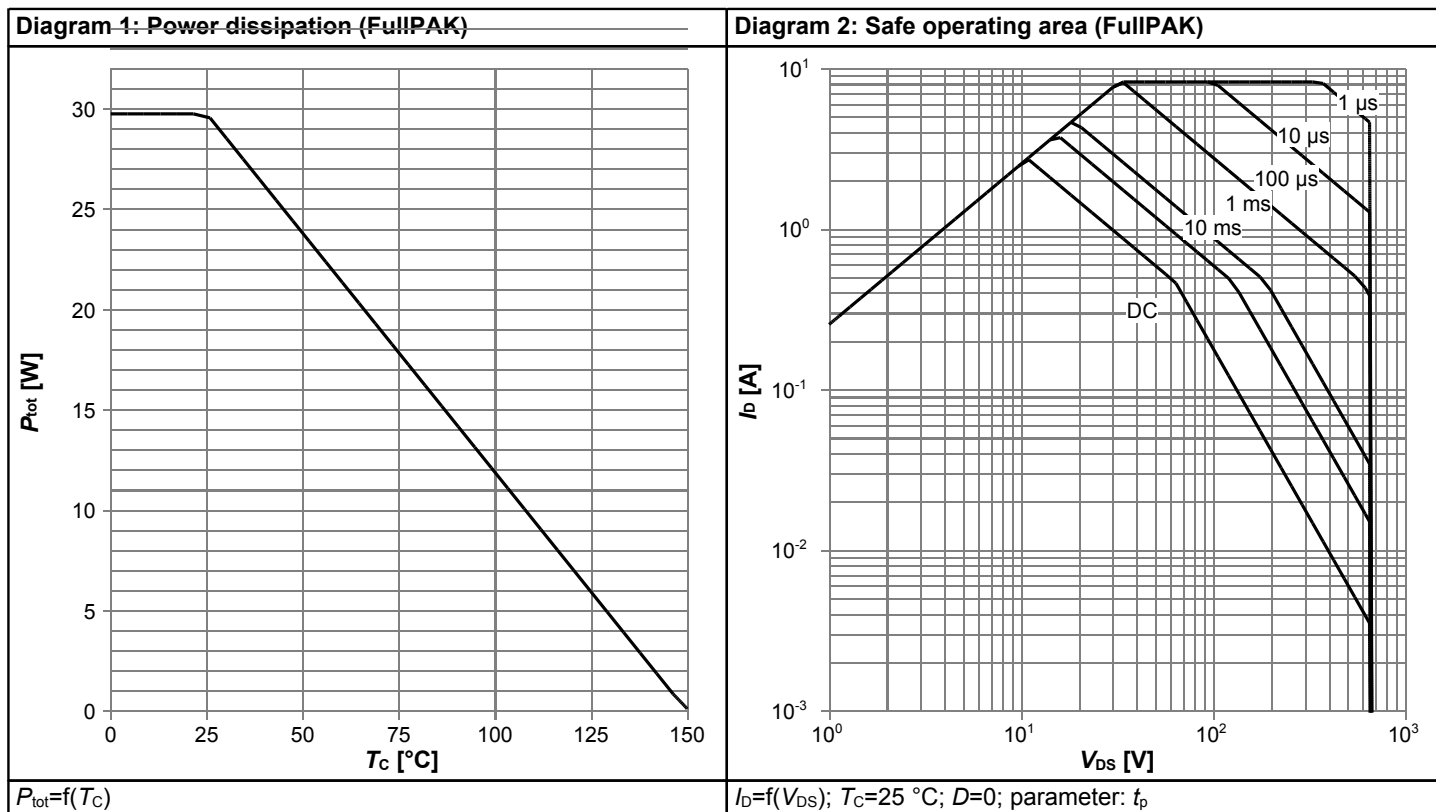
<sup>1)</sup>  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 480V

<sup>2)</sup>  $C_{o(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 480V

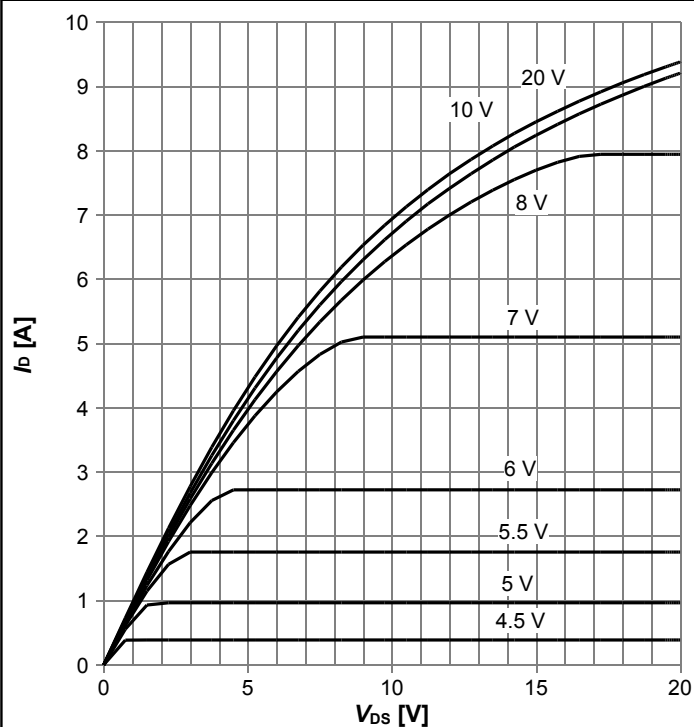
**Table 7 Reverse diode characteristics**

| Parameter                     | Symbol    | Values |      |      | Unit    | Note / Test Condition                                        |
|-------------------------------|-----------|--------|------|------|---------|--------------------------------------------------------------|
|                               |           | Min.   | Typ. | Max. |         |                                                              |
| Diode forward voltage         | $V_{SD}$  | -      | 0.9  | -    | V       | $V_{GS}=0V$ , $I_F=1.5A$ , $T_J=25^{\circ}C$                 |
| Reverse recovery time         | $t_{rr}$  | -      | 200  | -    | ns      | $V_R=400V$ , $I_F=1.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |
| Reverse recovery charge       | $Q_{rr}$  | -      | 0.9  | -    | $\mu C$ | $V_R=400V$ , $I_F=1.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |
| Peak reverse recovery current | $I_{rrm}$ | -      | 8    | -    | A       | $V_R=400V$ , $I_F=1.5A$ , $di_F/dt=100A/\mu s$ ; see table 8 |

## 4 Electrical characteristics diagrams

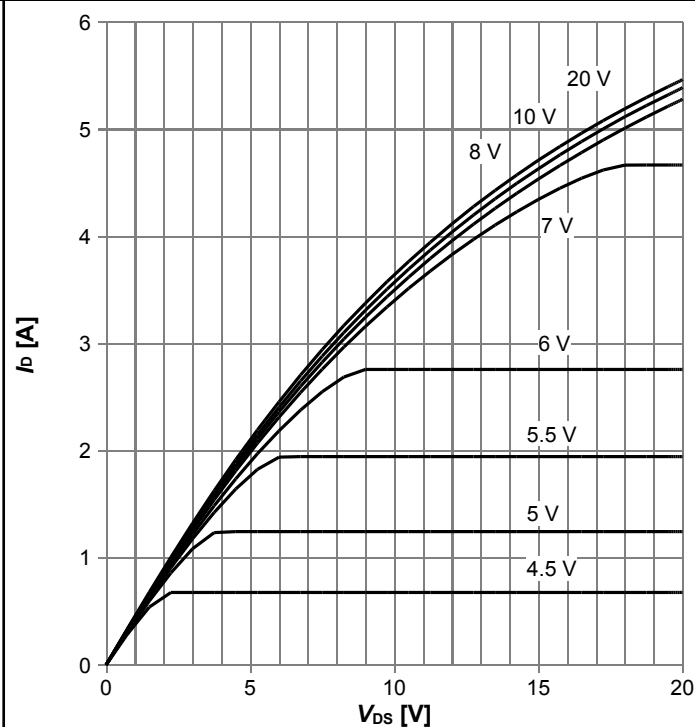


**Diagram 5: Typ. output characteristics**



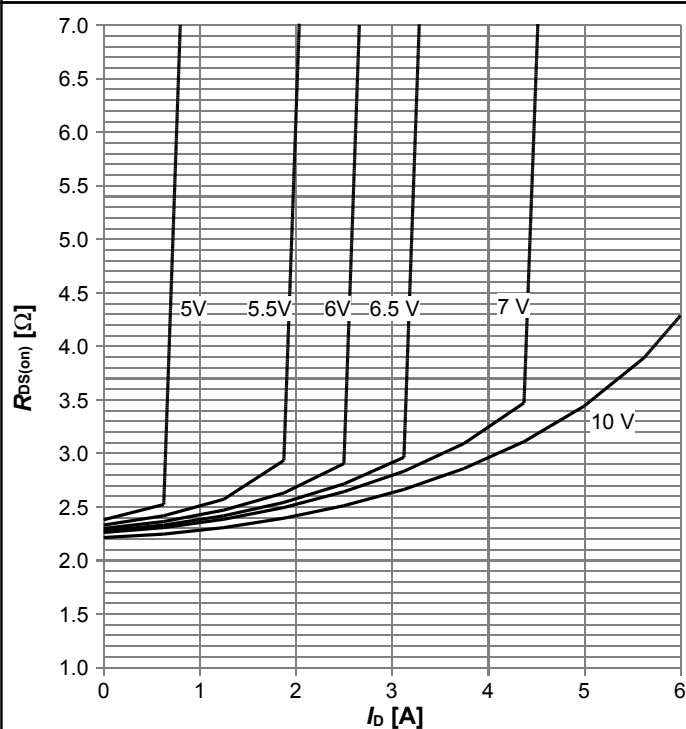
$I_D = f(V_{DS})$ ;  $T_J = 25\text{ °C}$ ; parameter:  $V_{GS}$

**Diagram 6: Typ. output characteristics**



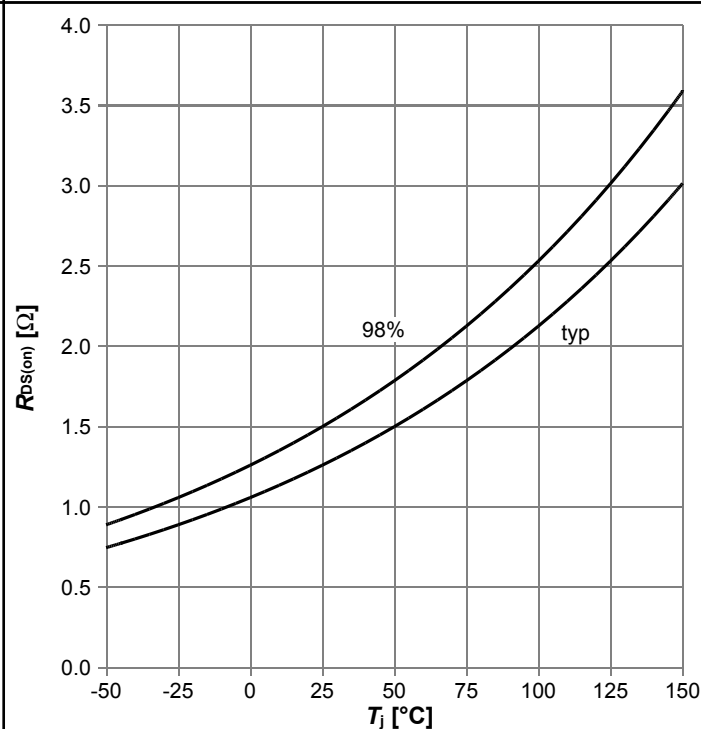
$I_D = f(V_{DS})$ ;  $T_J = 125\text{ °C}$ ; parameter:  $V_{GS}$

**Diagram 7: Typ. drain-source on-state resistance**



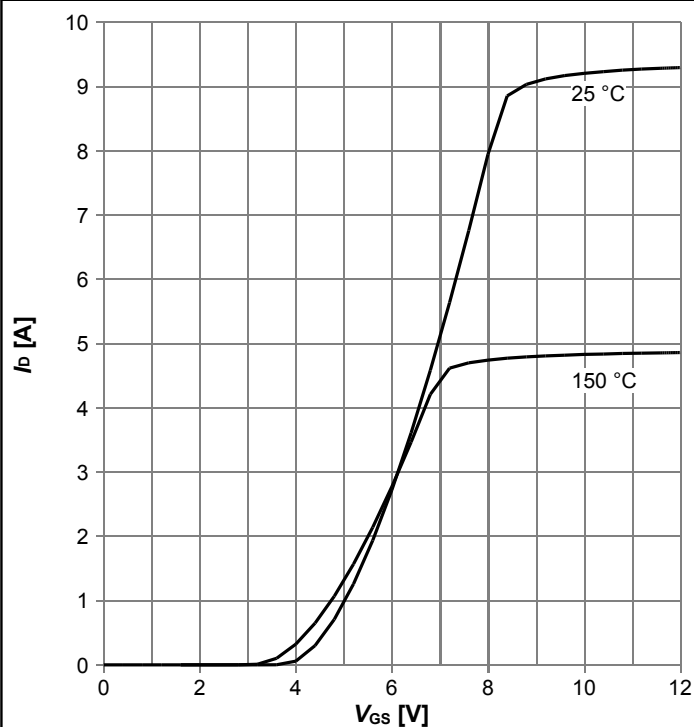
$R_{DS(on)} = f(I_D)$ ;  $T_J = 125\text{ °C}$ ; parameter:  $V_{GS}$

**Diagram 8: Drain-source on-state resistance**



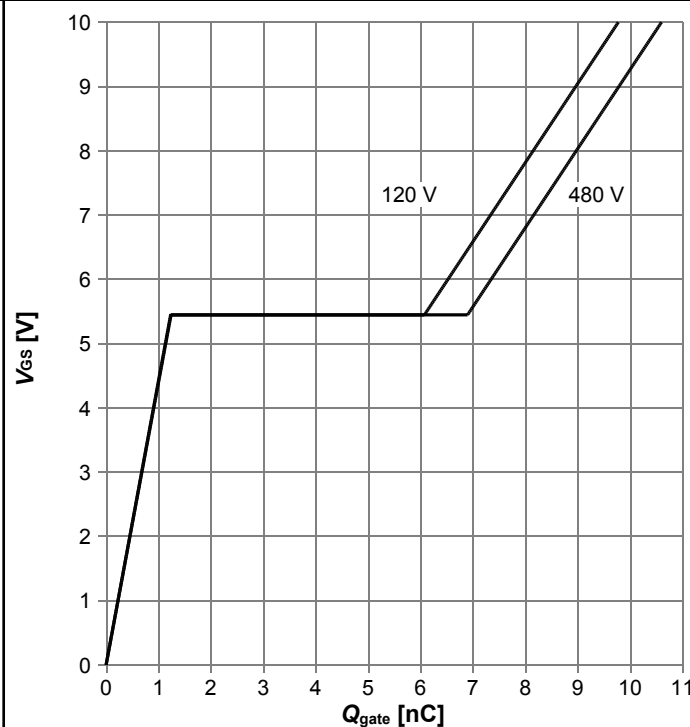
$R_{DS(on)} = f(T_J)$ ;  $I_D = 1.0\text{ A}$ ;  $V_{GS} = 10\text{ V}$

**Diagram 9: Typ. transfer characteristics**



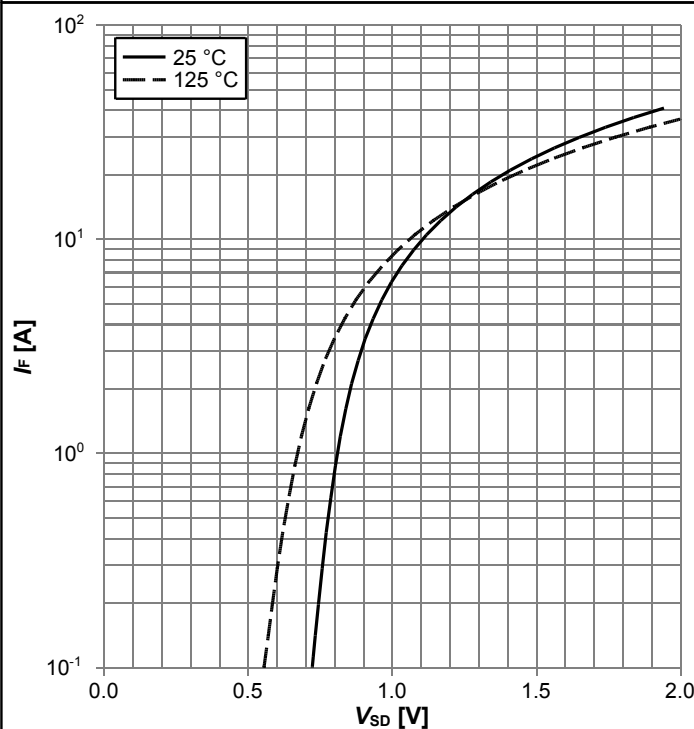
$I_D=f(V_{GS})$ ;  $V_{DS}=20V$ ; parameter:  $T_j$

**Diagram 10: Typ. gate charge**



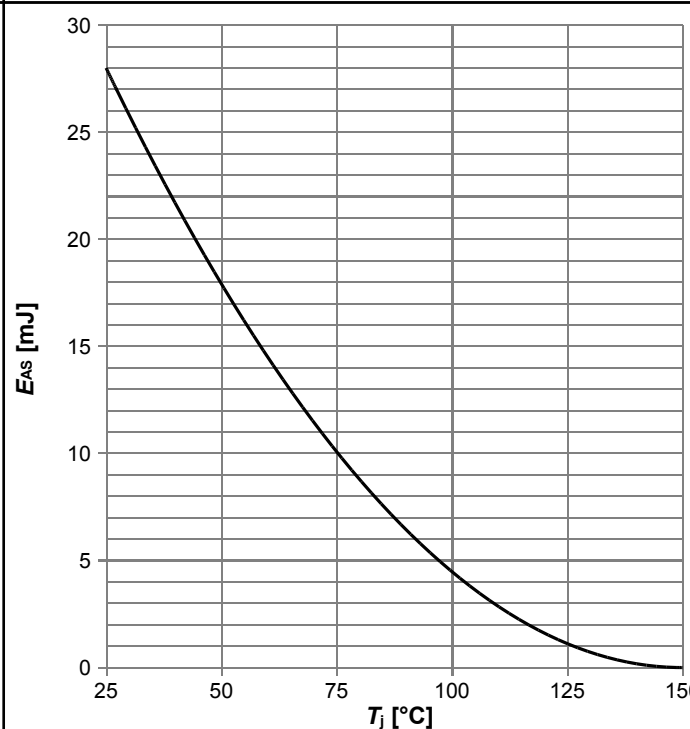
$V_{GS}=f(Q_{gate})$ ;  $I_D=1.5 A$  pulsed; parameter:  $V_{DD}$

**Diagram 11: Forward characteristics of reverse diode**



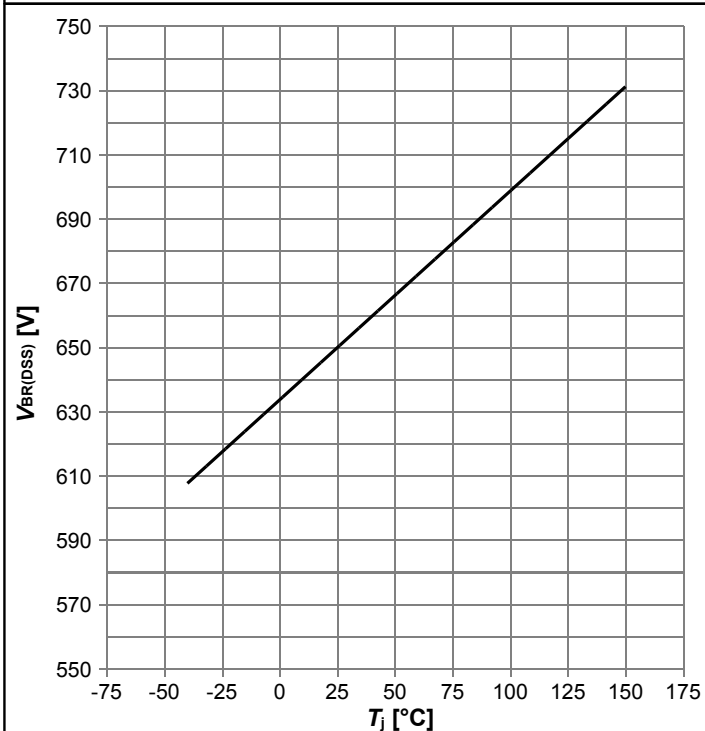
$I_F=f(V_{SD})$ ; parameter:  $T_j$

**Diagram 12: Avalanche energy**



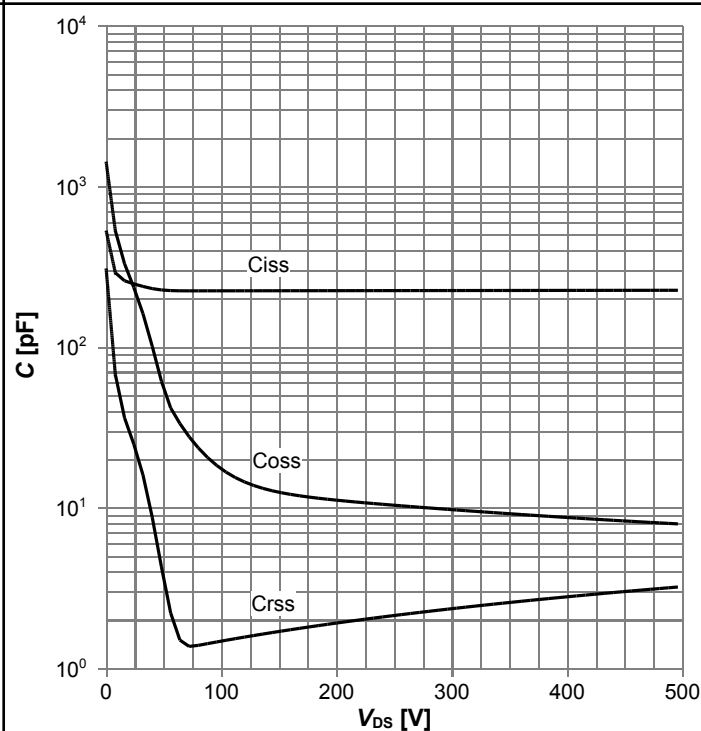
$E_{AS}=f(T_j)$ ;  $I_D=0.5 A$ ;  $V_{DD}=50 V$

**Diagram 13: Drain-source breakdown voltage**



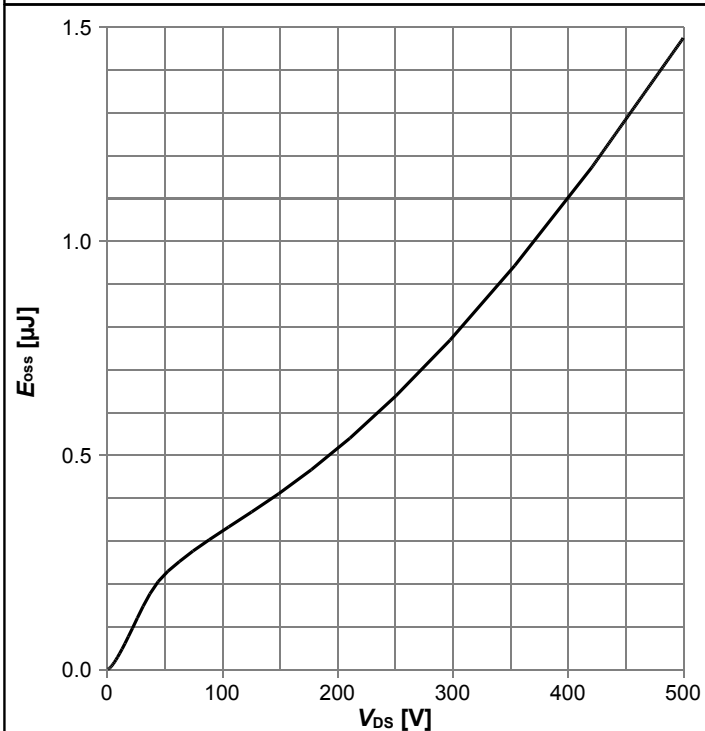
$V_{BR(DSS)} = f(T_j); I_D = 1.0 \text{ mA}$

**Diagram 14: Typ. capacitances**



$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$

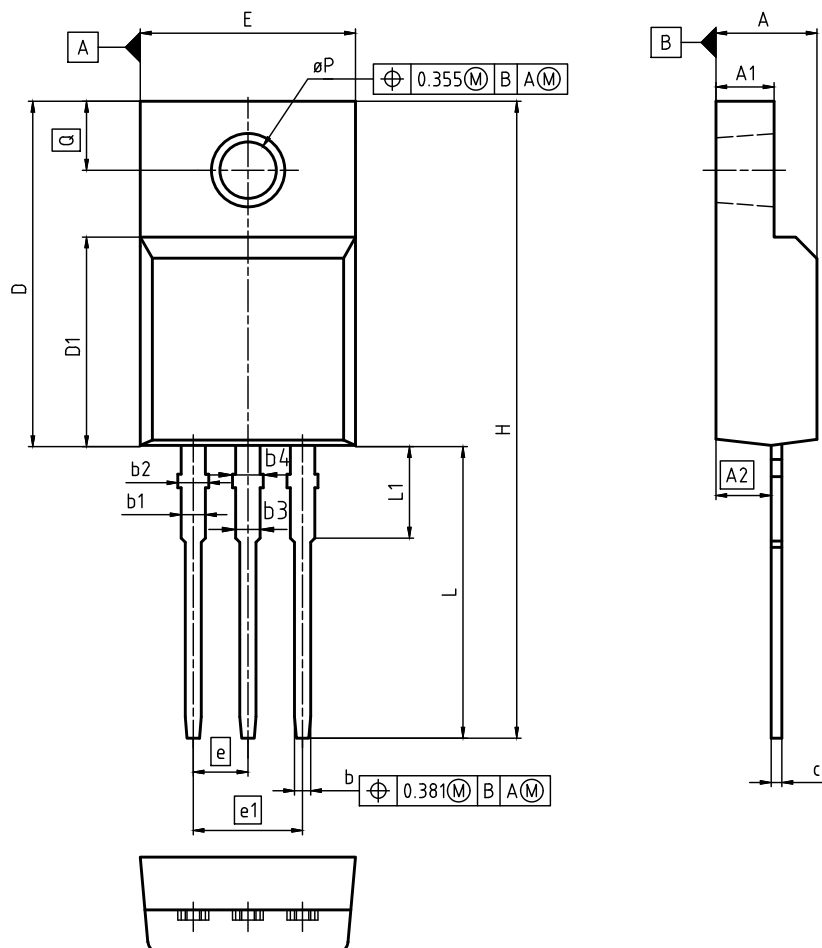
**Diagram 15: Typ. Coss stored energy**



$E_{oss} = f(V_{DS})$



## 6 Package Outlines



| DIM | MILLIMETERS |       | INCHES      |       |
|-----|-------------|-------|-------------|-------|
|     | MIN         | MAX   | MIN         | MAX   |
| A   | 4.50        | 4.90  | 0.177       | 0.193 |
| A1  | 2.34        | 2.85  | 0.092       | 0.112 |
| A2  | 2.42        | 2.86  | 0.095       | 0.113 |
| b   | 0.65        | 0.90  | 0.026       | 0.035 |
| b1  | 0.95        | 1.38  | 0.037       | 0.054 |
| b2  | 0.95        | 1.51  | 0.037       | 0.059 |
| b3  | 0.65        | 1.38  | 0.026       | 0.054 |
| b4  | 0.65        | 1.51  | 0.026       | 0.059 |
| c   | 0.40        | 0.63  | 0.016       | 0.025 |
| D   | 15.67       | 16.15 | 0.617       | 0.636 |
| D1  | 8.97        | 9.83  | 0.353       | 0.387 |
| E   | 10.00       | 10.65 | 0.394       | 0.419 |
| e   | 2.54 (BSC)  |       | 0.100 (BSC) |       |
| e1  | 5.08        |       | 0.200       |       |
| N   | 3           |       | 3           |       |
| H   | 28.70       | 29.75 | 1.130       | 1.171 |
| L   | 12.78       | 13.75 | 0.503       | 0.541 |
| L1  | 2.83        | 3.45  | 0.111       | 0.136 |
| øP  | 2.95        | 3.38  | 0.116       | 0.133 |
| Q   | 3.15        | 3.50  | 0.124       | 0.138 |

Dimensions do not include mold flash, protrusions or gate burrs

|                             |
|-----------------------------|
| DOCUMENT NO.<br>Z8B00003319 |
| SCALE<br>0 2.5 5mm          |
| EUROPEAN PROJECTION         |
| ISSUE DATE<br>05-05-2014    |
| REVISION<br>04              |

Figure 1 Outline PG-TO 220 FullPAK, dimensions in mm/inches

## 7 Appendix A

Table 11 Related Links

- IFX CoolMOS™ CE Webpage: [www.infineon.com](http://www.infineon.com)
- IFX CoolMOS™ CE application note: [www.infineon.com](http://www.infineon.com)
- IFX CoolMOS™ CE simulation model: [www.infineon.com](http://www.infineon.com)
- IFX Design tools: [www.infineon.com](http://www.infineon.com)

## Revision History

IPA65R1K5CE

Revision: 2016-02-26, Rev. 2.0

### Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0      | 2016-02-26 | Release of final version                     |

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